



BGA2715

MMIC wideband amplifier

Rev. 3 — 12 September 2011

Product data sheet

1. Product profile

1.1 General description

Silicon Monolithic Microwave Integrated Circuit (MMIC) wideband amplifier with internal matching circuit in a 6-pin SOT363 SMD plastic package.

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

1.2 Features and benefits

- Internally matched to 50 Ω
- Wide frequency range (3.3 GHz at 3 dB bandwidth)
- Flat 22 dB gain (± 1 dB up to 2.8 GHz)
- -8 dBm output power at 1dB compression point
- Good linearity for low current ($IP3_{out} = 2$ dBm)
- Low second harmonic, -30 dBc at $P_D = -40$ dBm
- Unconditionally stable ($K \geq 2$).

1.3 Applications

- LNB IF amplifiers
- Cable systems
- ISM
- General purpose.

1.4 Quick reference data

Table 1. Quick reference data

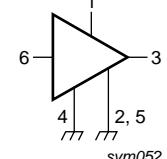
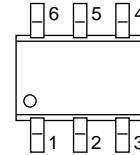
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_S	DC supply voltage		-	5	6	V
I_S	supply current		-	4.3	-	mA
$ s_{21} ^2$	insertion power gain	$f = 1$ GHz	-	22	-	dB
NF	noise figure	$f = 1$ GHz	-	2.6	-	dB
$P_{L(sat)}$	saturated load power	$f = 1$ GHz	-	-4	-	dBm



2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Symbol
1	V _S		
2, 5	GND2		
3	RF_OUT		
4	GND1		
6	RF_IN		



3. Ordering information

Table 3. Ordering information

Type number	Package			Version
	Name	Description		
BGA2715	-	plastic surface mounted package; 6 leads		SOT363

4. Marking

Table 4. Marking

Type number	Marking code
BGA2715	B6-

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _S	DC supply voltage	RF input AC coupled	-	6	V
I _S	supply current		-	8	mA
P _{tot}	total power dissipation	T _{sp} ≤ 90 °C	-	200	mW
T _{stg}	storage temperature		-65	+150	°C
T _j	junction temperature		-	150	°C
P _D	maximum drive power		-	-10	dBm

6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Typ	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	$P_{tot} = 200 \text{ mW}$; $T_{sp} \leq 90 \text{ }^{\circ}\text{C}$	300	K/W

7. Characteristics

Table 7. Characteristics

$V_S = 5 \text{ V}$; $I_S = 4.3 \text{ mA}$; $T_j = 25 \text{ }^{\circ}\text{C}$; measured on demo board; unless otherwise specified.

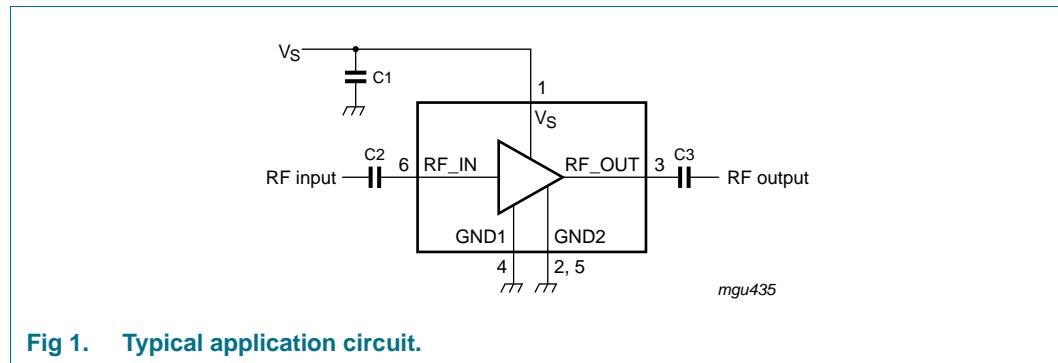
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
I_S	supply current		3.5	4.3	5.5	mA
$ s_{21} ^2$	insertion power gain	$f = 100 \text{ MHz}$	11	13.3	15	dB
		$f = 1 \text{ GHz}$	20	21.7	23	dB
		$f = 1.8 \text{ GHz}$	21	23.2	25	dB
		$f = 2.2 \text{ GHz}$	21	23.3	25	dB
		$f = 2.6 \text{ GHz}$	20	22.1	24	dB
		$f = 3 \text{ GHz}$	18	20.1	22	dB
$ s_{11} ^2$	input return losses	$f = 1 \text{ GHz}$	10	12	-	dB
		$f = 2.2 \text{ GHz}$	8	10	-	dB
$ s_{22} ^2$	output return losses	$f = 1 \text{ GHz}$	10	12	-	dB
		$f = 2.2 \text{ GHz}$	7	8.5	-	dB
$ s_{12} ^2$	isolation	$f = 1.6 \text{ GHz}$	53	54	-	dB
		$f = 2.2 \text{ GHz}$	38	39	-	dB
NF	noise figure	$f = 1 \text{ GHz}$	-	2.6	2.8	dB
		$f = 2.2 \text{ GHz}$	-	3.1	3.3	dB
B	bandwidth	at $ s_{21} ^2 - 3 \text{ dB}$ below flat gain at 1 GHz	3	3.3	-	GHz
K	stability factor	$f = 1 \text{ GHz}$	-	18	-	
		$f = 2.2 \text{ GHz}$	-	2.3	-	
$P_{L(\text{sat})}$	saturated load power	$f = 1 \text{ GHz}$	-5	-4.0	-	dBm
		$f = 2.2 \text{ GHz}$	-6	-5.0	-	dBm
$P_{L(1\text{dB})}$	load power	at 1 dB gain compression; $f = 1 \text{ GHz}$	-9	-8.0	-	dBm
		at 1 dB gain compression; $f = 2.2 \text{ GHz}$	-10	-8.5	-	dBm
IM2	second order intermodulation product	at $P_D = -40 \text{ dBm}$, $f_0 = 1 \text{ GHz}$	29	30	-	dBc
IP3 _{in}	input, third order intercept point	$f = 1 \text{ GHz}$	-21	-19.4	-	dBm
		$f = 2.2 \text{ GHz}$	-24	-22.7	-	dBm
IP3 _{out}	output, third order intercept point	$f = 1 \text{ GHz}$	0	2.3	-	dBm
		$f = 2.2 \text{ GHz}$	-1	0.6	-	dBm

8. Application information

[Figure 1](#) shows a typical application circuit for the BGA2715 MMIC. The device is internally matched to $50\ \Omega$, and therefore does not need any external matching. The value of the input and output DC blocking capacitors C2 and C3 should not be more than $100\ pF$ for applications above $100\ MHz$. However, when the device is operated below $100\ MHz$, the capacitor value should be increased.

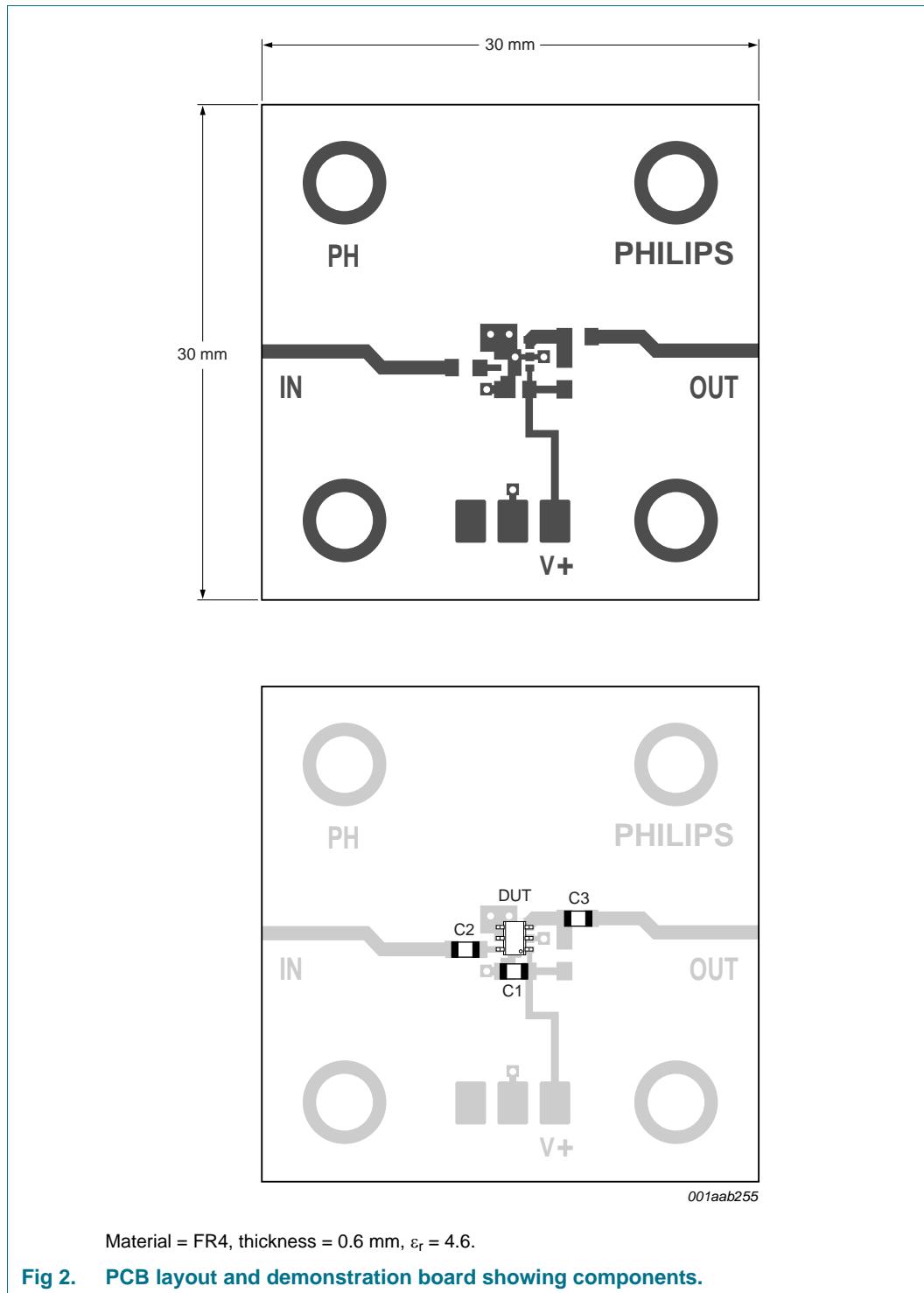
The $22\ nF$ supply decoupling capacitor, C1 should be located as close as possible to the MMIC.

The printed-circuit board (PCB) top ground plane, connected to pins 2, 4 and 5 must be as close as possible to the MMIC, and ideally directly beneath it. When using via holes, use multiple via holes, located as close as possible to the MMIC.



[Fig 1. Typical application circuit.](#)

[Figure 2](#) shows the PCB layout, used for the standard demonstration board.



Material = FR4, thickness = 0.6 mm, ϵ_r = 4.6.

Fig 2. PCB layout and demonstration board showing components.

8.1 Grounding and output impedance

If the grounding is not optimal, the gain becomes less flat and the 50Ω output matching becomes worse. To further increase output matching to 50Ω , a 12Ω resistor ($R1$) can be placed in series with $C3$ (see [Figure 3](#)). This will significantly improve the output impedance, at the cost of 1 dB gain and 1 dB output power.

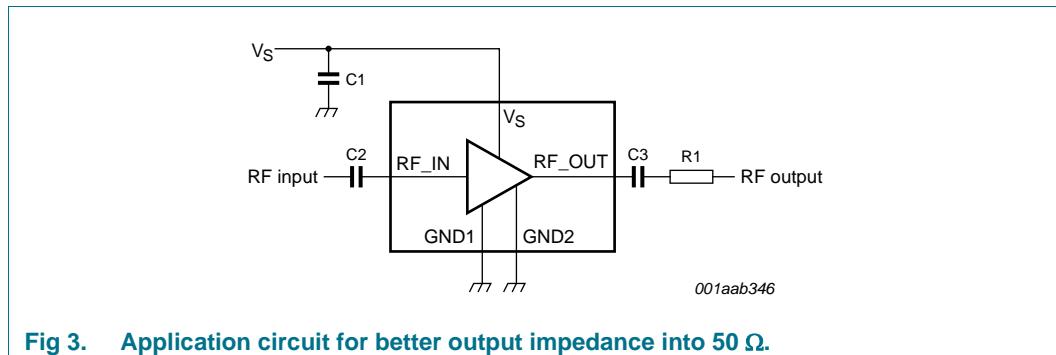


Fig 3. Application circuit for better output impedance into $50\ \Omega$.

8.2 Application examples

The excellent wideband characteristics of the MMIC make it an ideal building block in IF amplifiers such as LNBs (see [Figure 4](#)).

As second amplifier after an LNA, the MMIC offers an easy matching, low noise solution (see [Figure 5](#)).

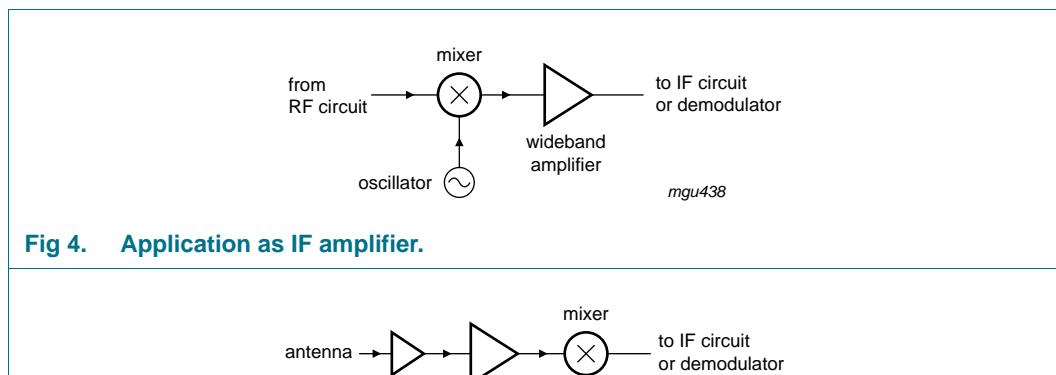


Fig 4. Application as IF amplifier.

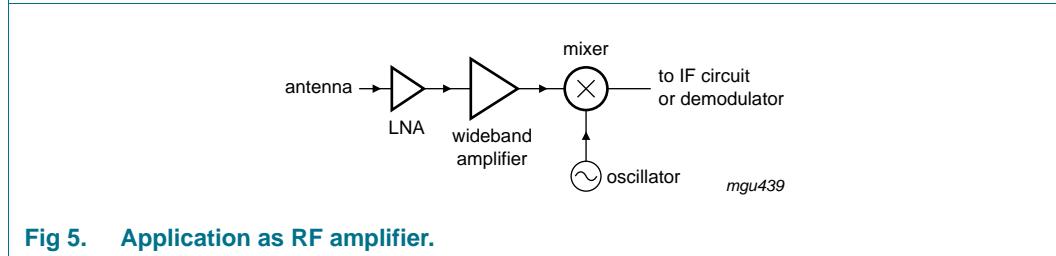
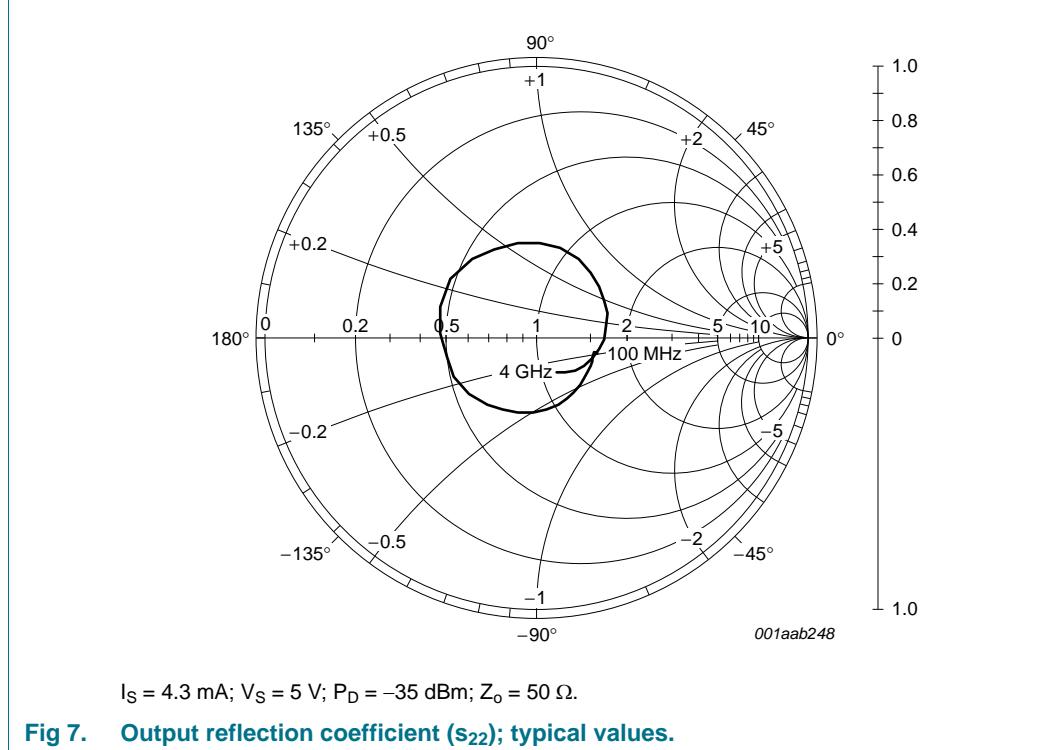
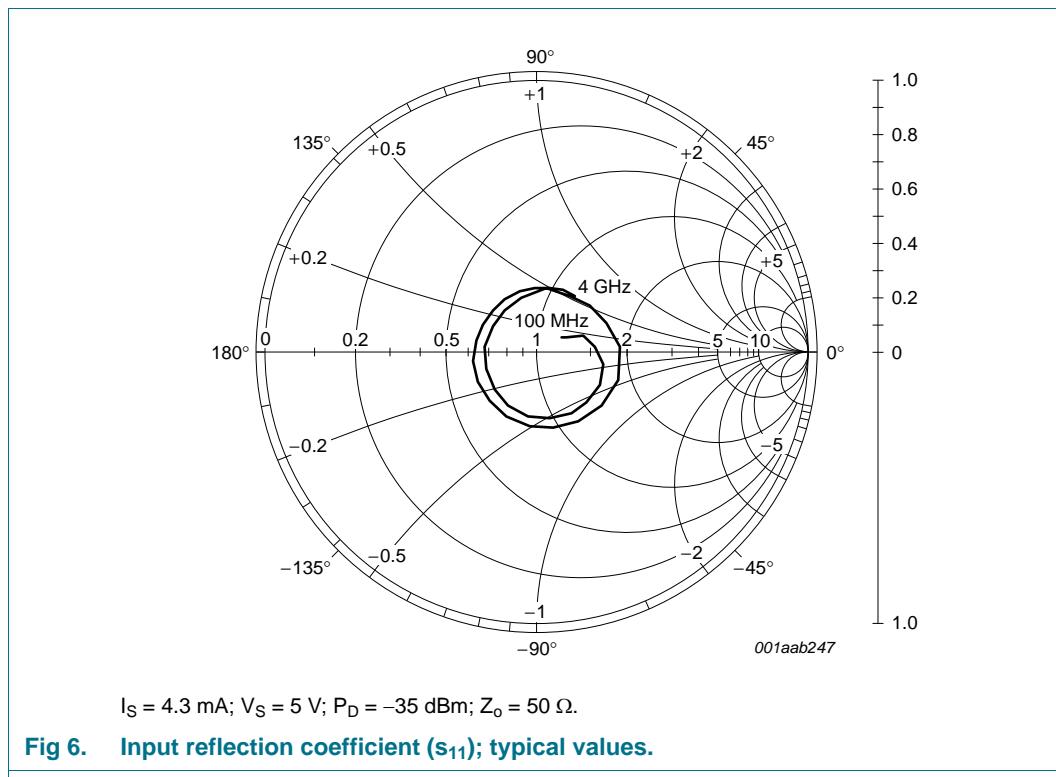
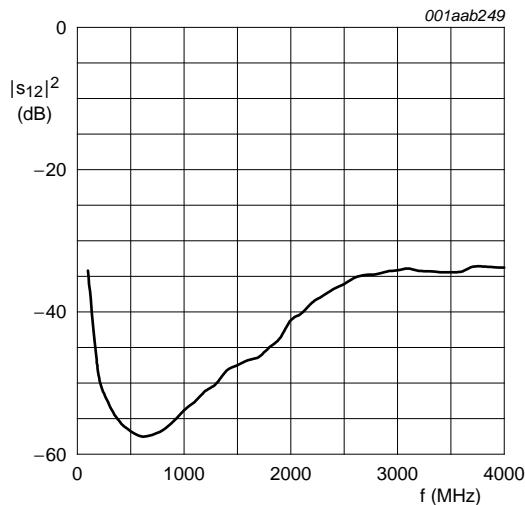


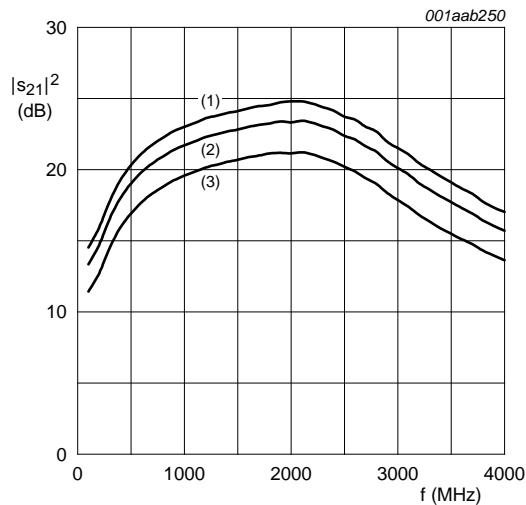
Fig 5. Application as RF amplifier.





$I_S = 4.3$ mA; $V_S = 5$ V; $P_D = -35$ dBm; $Z_0 = 50 \Omega$.

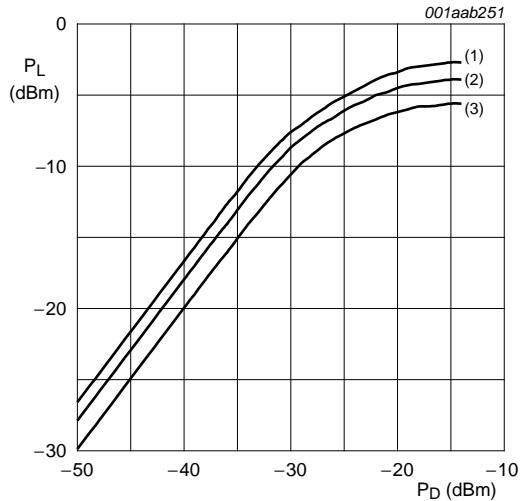
Fig 8. Isolation ($|s_{12}|^2$) as a function of frequency; typical values.



$P_D = -35$ dBm; $Z_0 = 50 \Omega$.

- (1) $I_S = 4.7$ mA; $V_S = 5.5$ V.
- (2) $I_S = 4.3$ mA; $V_S = 5$ V.
- (3) $I_S = 3.9$ mA; $V_S = 4.5$ V.

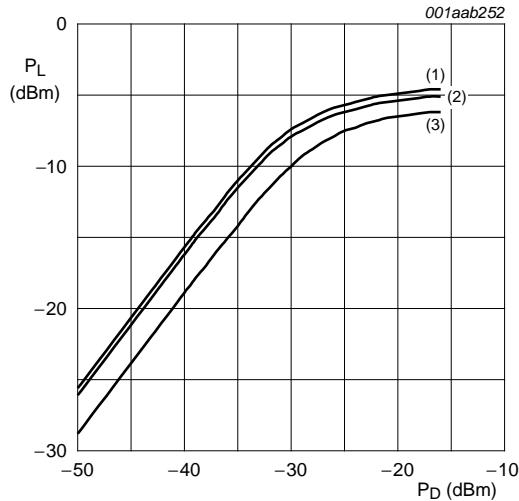
Fig 9. Insertion gain ($|s_{21}|^2$) as a function of frequency; typical values.



$f = 1$ GHz; $Z_0 = 50 \Omega$.

- (1) $V_S = 5.5$ V.
- (2) $V_S = 5$ V.
- (3) $V_S = 4.5$ V.

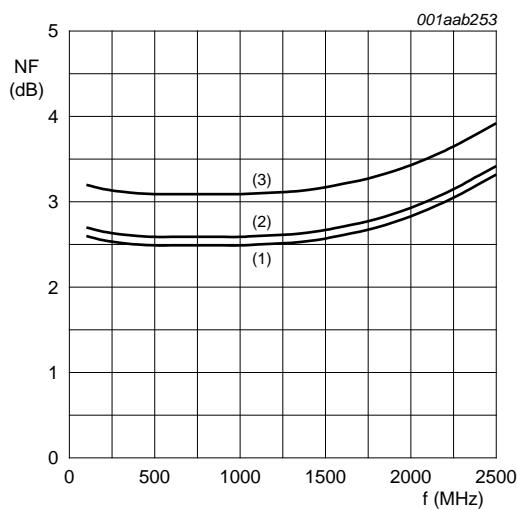
Fig 10. Load power as a function of drive power at 1 GHz; typical values.



$f = 2.2$ GHz; $Z_0 = 50 \Omega$.

- (1) $V_S = 5.5$ V.
- (2) $V_S = 5$ V.
- (3) $V_S = 4.5$ V.

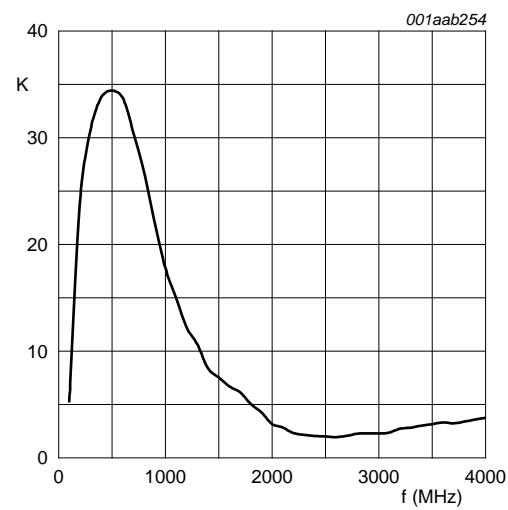
Fig 11. Load power as a function of drive power at 2.2 GHz; typical values.



$Z_0 = 50 \Omega$.

- (1) $I_S = 4.7 \text{ mA}; V_S = 5.5 \text{ V}$.
- (2) $I_S = 4.3 \text{ mA}; V_S = 5 \text{ V}$.
- (3) $I_S = 3.9 \text{ mA}; V_S = 4.5 \text{ V}$.

Fig 12. Noise figure as a function of frequency; typical values.



$I_S = 4.3 \text{ mA}; V_S = 5 \text{ V}; Z_0 = 50 \Omega$.

Fig 13. Stability factor as a function of frequency; typical values.

Table 8. Scattering parameters

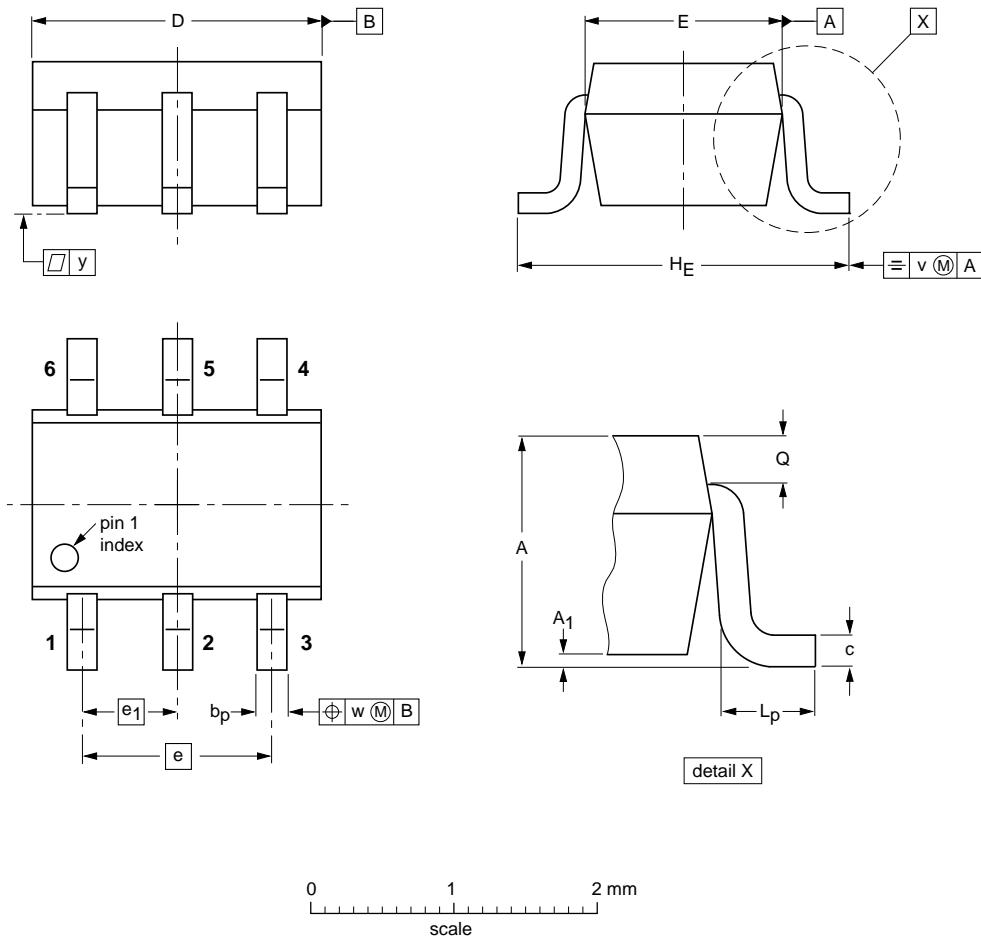
 $V_S = 5 \text{ V}$; $I_S = 4.3 \text{ mA}$; $P_D = -35 \text{ dBm}$; $Z_0 = 50 \Omega$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

f (MHz)	S ₁₁		S ₂₁		S ₁₂		S ₂₂		K-factor
	Magnitude (ratio)	Angle (deg)	Magnitude (ratio)	Angle (deg)	Magnitude (ratio)	Angle (deg)	Magnitude (ratio)	Angle (deg)	
100	0.100503	27.76918	4.641604	13.82793	0.01958	-110.345	0.231889	-14.37137	5.2
200	0.121228	24.6812	5.427784	7.997073	0.003611	-114.8849	0.219504	-14.09179	23.9
400	0.217855	3.974108	7.924499	-7.594877	0.001688	-77.39562	0.223868	-23.69087	33.8
600	0.26219	-28.08926	9.807075	-30.92853	0.001336	-170.6765	0.22656	-34.95361	33.8
800	0.26297	-61.21535	11.13563	-55.31486	0.001473	124.9044	0.237554	-48.11004	26.8
1000	0.241089	-96.9469	12.17817	-80.09316	0.002036	155.3396	0.25378	-63.76927	17.8
1200	0.211289	-136.4953	13.02575	-104.2842	0.002785	147.5162	0.271479	-82.31896	12.2
1400	0.18828	175.4377	13.60797	-128.89	0.003866	138.7051	0.287623	-104.1092	8.4
1600	0.187898	128.6387	14.14423	-153.3766	0.004588	124.9325	0.307361	-125.9161	6.7
1800	0.231527	80.79592	14.54321	-179.671	0.005641	120.4153	0.338893	-154.6072	5.1
2000	0.257172	40.08414	14.65137	154.6647	0.008743	103.0426	0.352132	177.7152	3.2
2200	0.303945	2.249913	14.61385	127.2237	0.011662	94.4722	0.378963	145.8774	2.3
2400	0.311735	-39.67469	13.78165	100.012	0.014471	54.07247	0.359508	115.0129	2.0
2600	0.288113	-77.37179	12.75107	74.12332	0.017402	33.11605	0.349807	88.0727	1.9
2800	0.265404	-114.1115	11.55715	48.40486	0.016703	7.697541	0.327615	61.52393	2.3
3000	0.24479	-151.8463	10.12992	25.3978	0.019651	-11.0858	0.296875	39.00544	2.3
3200	0.225353	170.8795	8.961976	3.789364	0.018743	-28.17932	0.27147	18.63863	2.8
3400	0.219366	136.6841	8.061087	-16.85382	0.019073	-45.60266	0.247253	-1.617895	3.0
3600	0.226203	106.1421	7.318683	-37.20896	0.019248	-60.69421	0.217973	-21.22008	3.3
3800	0.23349	78.62692	6.619309	-56.90074	0.020895	-72.89823	0.184766	-40.71164	3.4
4000	0.244216	54.63669	6.105669	-75.98154	0.020531	-85.18773	0.150082	-60.81328	3.8

9. Package outline

Plastic surface-mounted package; 6 leads

SOT363



DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1 max	b_p	c	D	E	e	e_1	H_E	L_p	Q	v	w	y
mm	1.1 0.8	0.1	0.30 0.20	0.25 0.10	2.2 1.8	1.35 1.15	1.3	0.65	2.2 2.0	0.45 0.15	0.25 0.15	0.2	0.2	0.1

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT363			SC-88			04-11-08 06-03-16

Fig 14. Package outline; SOT363 (SC-88).

10. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BGA2715 v.3	20110912	Product data sheet	-	BGA2715 v.2
Modifications:	<ul style="list-style-type: none">The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.Legal texts have been adapted to the new company name where appropriate.Package outline drawings have been updated to the latest version.			
BGA2715 v.2 (9397 750 13291)	20040924	Product data sheet	-	BGA2715_N v.1
BGA2715_N v.1 (9397 750 12826)	20040202	Preliminary data sheet	-	-

11. Legal information

11.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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